

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination BRICAUD ET AL.	
		Examiner Ross N. Gushi	Art Unit 2833	Page 1 of 3

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	A	US-6,743,035 B1	06-2004	Yang, Hui-Ping	439/326
	B	US-6,719,579 B2	04-2004	Tisserand et al.	439/331
	C	US-6,663,408 B2	12-2003	Sato, Shigeru	439/331
	D	US-6,547,138 B1	04-2003	Braun et al.	235/441
	E	US-6,485,319 B2	11-2002	Bricaud et al.	439/188
	F	US-6,471,550 B2	10-2002	Maiterth et al.	439/631
	G	US-6,468,101 B2	10-2002	Suzuki, Mitsuo	439/326
	H	US-6,383,027 B2	05-2002	Cabane et al.	439/630
	I	US-6,358,074 B2	03-2002	Bricaud et al.	439/188
	J	US-6,334,786 B1	01-2002	Lee, Ipson	439/331
	K	US-6,319,036 B1	11-2001	Zheng et al.	439/326
	L	US-6,273,739 B1	08-2001	Konno et al.	439/331
✓	M	US-6,241,545 B1	06-2001	Bricaud et al.	439/326

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/054,432	BRICAUD ET AL.	
Examiner		Art Unit		Page 2 of 3
Ross N. Gushi		2833		

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	A	US-6,234,810 B1	05-2001	Schnell et al.	439/76.1
	B	US-6,227,893 B1	05-2001	Kaneko, Tetsuya	439/326
	C	US-6,220,882 B1	04-2001	Simmel et al.	439/326
	D	US-6,210,193 B1	04-2001	Ito et al.	439/326
	E	US-6,176,721 B1	01-2001	Gottardo et al.	439/260
	F	US-6,174,188 B1	01-2001	Martucci, Roberto	439/326
	G	US-6,149,466 A	11-2000	Briculaud et al.	439/630
	H	US-6,106,317 A	08-2000	Michaelis et al.	439/326
	I	US-6,099,337 A	08-2000	Chan, Wen-Yao	439/326
	J	US-6,095,868 A	08-2000	Hyland et al.	439/630
	K	US-6,062,889 A	05-2000	Hyland et al.	439/326
	L	US-6,024,593 A	02-2000	Hyland, James Henry	439/326
	M	US-5,996,891 A	12-1999	Braun, Gerhard	235/441

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination BRICAUD ET AL.	
		Examiner	Art Unit	Page 3 of 3
		Ross N. Gushi	2833	

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	A	US-5,984,707 A	11-1999	Kuwata, Tomonari	439/326
	B	US-5,961,338 A	10-1999	Wu et al.	439/326
	C	US-5,813,878 A	09-1998	Kuwata et al.	439/326
Y	D	US-5,603,629 A	02-1997	DeFrasne et al.	439/331
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.